Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/511,525	CHANG ET AL.
Examiner	Art Unit
Rita J. Desai	1625

SEARCHED					
Class	Subclass	Date	Examiner		
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	279	/	1		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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